



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Inventor: Chen. Yi

Group Art Unit: Not Yet

Assigned

Serial No.: 10/602997

Examiner: Not Yet Assigned

Amanda J. Gorthy

Filed: June 23, 2003

Title: Simplified Comparator with Digitally Controllable Hysteresis and

Bandwidth

CERTIFICATE OF MAILING

I hereby certify that this correspondence, and the documents attached hereto, are being deposited with the United States Postal Service as First Class shall in an envelope addressed to Commissioner for Patents. Washington. D.C. 20231 on this date.

Date: September 17, 2003

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir

In compliance with the duty of disclosure under 37 C.F.R. § 1.56, and in accordance with the practice under 37 C.F.R. § 1.97 and § 1.98, the Examiner's attention is directed to the document listed on the enclosed Form PTO-1449. A copy of the listed information is also enclosed.

This Information Disclosure Statement is being filed within three months of the U.S. filing date or before the mailing date of a first Office Action on the merits. No certification or fee is required (37 CFR §1.97(b)).

CONCLUSION

The Commissioner is hereby authorized to charge any additional fees which may be required, or credit any over-payment to deposit account 50-1236.

MP0289

10/602997

Supplemental Information Disclosure Statement

It is respectfully requested that the above information be considered by the Examiner and that a copy of the enclosed Form PTO-1449 be initialed and returned indicating that such information has been considered.

Respectfully submitted,

Eric B. Janofsky

Attorney for Applicant Registration No. 30759

Please address all correspondence to:

Eric B. Janofsky
General Patent Counsel
Marvell Semiconductor, Inc.
700 First Avenue, Mail Stop 509
Sunnyvale, CA 94089
General Telephone Number (408) 222-2500
Facsimile (408) 752-9034
Emsil: janofsky@marvell.com
Customer No. 23624

Date: September 17, 2003

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Form PTO-1449 DEPARTMENT OF COMMERCE				SERIAL NO.	SERIAL NO. ATT		TY DOCKET NO.	
(REV 8-83) 2003 PATENT AND TRADEMARK OFFICE				10/602,997	MP0289		39	
B SEP I L DOUS E				APPLICANT				
information disclosure citation				Chen, Yi				
(USE SEPERAL SHEETS IF NECESSARY)				FILING DATE		GROUP:		
PAGE 1 OF 1				June 23, 2003		Not Yet As	signed	
U.S. PATENT DOCUMENTS								
E.I.	DOCUMENT NUMBER		DATE	· NAME	CLAS	S SUBCLAS	FILING DATE	
FOREIGN PATENT DOCUMENTS								
E.I.	E.I. DOCUMENT NUMBER		DATE	COUNTRY	CLAS	S SUBCLAS	TRANS- LATION	
OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)								
	1 "IEEE Standard Test Access Port and Boundary-Scan Architecture," IEEE Standard 1149.1, 2001, pp 1-200.							
EXAMINER				DATE CONSIDERED				

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.